


**PRODUCT / PROCESS CHANGE NOTIFICATION**

**1. PCN basic data**

<b>1.1 Company</b>		STMicroelectronics International N.V
<b>1.2 PCN No.</b>	ADG/20/12360	
<b>1.3 Title of PCN</b>	SPC584Cx, SPC58ECx (FC80) : Design Improvement and New Manufacturing Plants Activation (Diffusion, EWS, Assembly, Testing)	
<b>1.4 Product Category</b>	see list	
<b>1.5 Issue date</b>	2020-09-29	

**2. PCN Team**

<b>2.1 Contact supplier</b>	
<b>2.1.1 Name</b>	ROBERTSON HEATHER
<b>2.1.2 Phone</b>	+1 8475853058
<b>2.1.3 Email</b>	heather.robertson@st.com
<b>2.2 Change responsibility</b>	
<b>2.2.1 Product Manager</b>	Luca RODESCHINI
<b>2.1.2 Marketing Manager</b>	Matteo MOIOLI
<b>2.1.3 Quality Manager</b>	Alberto MERVIC

**3. Change**

<b>3.1 Category</b>	<b>3.2 Type of change</b>	<b>3.3 Manufacturing Location</b>
General Product & Design	(Not Defined)	see enclosed details

**4. Description of change**

	<b>Old</b>	<b>New</b>
<b>4.1 Description</b>	see enclosed details	see enclosed details
<b>4.2 Anticipated Impact on form,fit, function, quality, reliability or processability?</b>	No Impacts	

**5. Reason / motivation for change**

<b>5.1 Motivation</b>	Improvement of silicon design (bug fix) and implementation of new manufacturing roadmap (current one retained as back-up)
<b>5.2 Customer Benefit</b>	QUALITY IMPROVEMENT

**6. Marking of parts / traceability of change**

<b>6.1 Description</b>	Dedicated Finished Good Codes
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**7. Timing / schedule**

<b>7.1 Date of qualification results</b>	2021-12-17
<b>7.2 Intended start of delivery</b>	2022-01-31
<b>7.3 Qualification sample available?</b>	Upon Request

**8. Qualification / Validation**

<b>8.1 Description</b>			
<b>8.2 Qualification report and qualification results</b>	In progress	<b>Issue Date</b>	

**9. Attachments (additional documentations)**

12360 Public product.pdf  
12360 Details.pdf

10. Affected parts		
10. 1 Current		10.2 New (if applicable)
10.1.1 Customer Part No	10.1.2 Supplier Part No	10.1.2 Supplier Part No
	SPC58EC80C3QMC0Y	
	SPC58EC80E1Q0C0Y	
	SPC58EC80E3QMC0Y	
	SPC58EC80E5QMC0Y	
	SPC58EC80E7QMC0Y	

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## PRODUCT/PROCESS CHANGE NOTIFICATION

**SUBJECT**      **SPC584Cx, SPC58ECx (FC80) : Design Improvement and New Manufacturing Plants Activation (Diffusion, EWS, Assembly, Testing)**

<b>IMPACTED PRODUCTS</b>	<p>ST silicon line FC80 (Chorus-4M) assembled in the following different packages:</p> <ul style="list-style-type: none"> <li> FPBGA 17X17X1.8 292</li> <li> LQFP 176L 24X24X1.4 Expad</li> <li> TQFP 144 20x20x1.0 1.0 Expad</li> <li> TQFP 100 14x14x1.0 1.0 Expad</li> <li> TQFP 64 10x10x1.0 1.0 ExPad</li> </ul> <p>Identified by part numbers starting with SPC584Cx and SPC58ECx.</p>																																				
<b>MANUFACT. STEP</b>	<p>Silicon design improvement (bug fix), diffusion plant, electrical wafer probing plant (EWS), assembly plant and electrical final test, depending on package type, as per the following table:</p> <table border="1" style="width: 100%; border-collapse: collapse; margin-top: 10px;"> <thead> <tr style="background-color: #0070C0; color: white;"> <th>Package Description</th> <th>Design</th> <th>Diffusion</th> <th>EWS</th> <th>Assembly</th> <th>Final Test</th> </tr> </thead> <tbody> <tr> <td>FPBGA 17X17X1.8 292</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">-</td> <td style="text-align: center;">-</td> </tr> <tr> <td>LQFP 176L 24X24X1.4 Expad</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> </tr> <tr> <td>TQFP 144 20x20x1.0 1.0 Expad</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> </tr> <tr> <td>TQFP 100 14x14x1.0 1.0 Expad</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> </tr> <tr> <td>TQFP 64 10x10x1.0 1.0 ExPad</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> <td style="text-align: center;">•</td> </tr> </tbody> </table>	Package Description	Design	Diffusion	EWS	Assembly	Final Test	FPBGA 17X17X1.8 292	•	•	•	-	-	LQFP 176L 24X24X1.4 Expad	•	•	•	•	•	TQFP 144 20x20x1.0 1.0 Expad	•	•	•	•	•	TQFP 100 14x14x1.0 1.0 Expad	•	•	•	•	•	TQFP 64 10x10x1.0 1.0 ExPad	•	•	•	•	•
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<b>INVOLVED PLANT</b>	<p>Different sites are involved:</p> <ul style="list-style-type: none"> <li> Design: not applicable</li> <li> Diffusion: Subcontractor Samsung (recipient site)</li> <li> EWS: Subcontractor KYEC (recipient site)</li> <li> Assembly: ST Muar and Subcontractor ASE (recipient sites)</li> <li> Final Test: ST Muar and Subcontractor under definition (recipient sites)</li> </ul> <p>depending on the different package type.</p>																																				

**CHANGE REASON**

Improvement of silicon design (bug fix) and implementation of new manufacturing roadmap (current one retained as back-up).

**CHANGE DESCRIPTION**

Different changes are collected in this notification:

1. Design improvement: from silicon release Cut 1.1 to Cut 2.0 to remove existing bugs, maintaining full SW compatibility (list of changes available). Cut 2.0 will be directly implemented in the new diffusion site (Samsung) but, to mitigate the risk, solution has been already validated and qualified in ST Crolles plant. List of errata fixes is attached as Annex 1 to this notification.
2. Diffusion transfer: from current ST Crolles to Subcontractor Samsung.
3. EWS transfer: from ST Rousset to Subcontractor KYEC. Both sites will remain active.
4. Assembly transfer: from ST Malta and Subcontractor Amkor to ST Muar and Subcontractor ASE (except for BGA package). Both sites will remain active in case of Malta to Muar.
5. Final Test transfer: from ST Malta to ST Muar and Subcontractor under definition (except for BGA package). Both sites will remain active.

Different combinations are summarized in the following table:

Package Description	Silicon Revision		Diffusion		EWS		Assembly		Final Test	
	Current	New	Current	New	Current	New	Current	New	Current	New
FPBGA 17X17X1.8 292	Cut 1.1	Cut 2.0	ST Crolles	Samsung	ST Rousset	KYEC ST Rousset	ST Malta	ST Malta	ST Malta	ST Malta
LQFP 176L 24X24X1.4 Expad	Cut 1.1	Cut 2.0	ST Crolles	Samsung	ST Rousset	KYEC ST Rousset	ST Malta	ASE ST Malta	ST Malta	ST Malta Subco
TQFP 144 20x20x1.0 1.0 Expad	Cut 1.1	Cut 2.0	ST Crolles	Samsung	ST Rousset	KYEC ST Rousset	ST Malta	ST Malta Subco	ST Malta	ST Malta Subco
TQFP 100 14x14x1.0 1.0 Expad	Cut 1.1	Cut 2.0	ST Crolles	Samsung	ST Rousset	KYEC ST Rousset	ST Malta	ST Malta ST Muar	ST Malta	ST Muar ST Malta
TQFP 64 10x10x1.0 1.0 ExPad	Cut 1.1	Cut 2.0	ST Crolles	Samsung	ST Rousset	KYEC ST Rousset	Amkor	ST Muar	ST Malta	ST Muar

**TRACEAB.**

New dedicated Commercial Product code (silicon revision) and dedicated Finished Good code (Internal Part Number).

**VALIDATION**

Presently in progress, according to AEC-Q100 / Q006 qualification plan for Integrated Circuits and ZVEI Guidelines:



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nature:		name of features below:		Show Text		Values: Show Rows		Values: Show Columns		Evaluation level A / B / C	
AEC-Q100 Revision H											
Assessment of impact on Supply Chain regarding following aspects:		- contractual agreements		- process capability and quality of customer		- form, fit, function, quality performance, reliability		Remain		9 risks within Supply Chain?	
Type of class		No		Yes		Yes		No		Yes	
AMT		No		Yes		Yes		No		Yes	
DATA SHEET		No		Yes		Yes		No		Yes	
DESIGN		No		Yes		Yes		No		Yes	
IDENT		No		Yes		Yes		No		Yes	
PROCESS - WATER PRODUCTION		No		Yes		Yes		No		Yes	
PROCESS - ASSEMBLY		No		Yes		Yes		No		Yes	
SABLE DIE		No		Yes		Yes		No		Yes	
PACKING/SHIPPING		No		Yes		Yes		No		Yes	
EQUIPMENT		No		Yes		Yes		No		Yes	
TEST FLOW		No		Yes		Yes		No		Yes	
MATERIAL PERFORMANCE TEST RESULTS (on the basis of AEC-Q100 Revision H)		Includes integrated circuits (e.g. ASICs, µ-Controller, memories, voltage regulators, smart power devices, logic devices, analog devices, ...)								additional to AEC-Q100	
M2		Thermal Humidity Bias or soaked HAST									
M3		Autoclave or Unsoaked HAST									
M4		Temperature Cycling									
M5		Power Temperature Cycling									
M6		High Temperature Operating Life									
M7		Early Life Failure Rate									
M8		WEM: Endurance, Gate Retention, and Operational Life									
M9		Wire Bond Shear									
M10		Wire Bond Pull									
M11		Solderability									
M12		Physical Dimensions									
M13		Solder Ball Shear									
M14		Lead Integrity									
M15		Electromigration									
M16		Time Depending Dielectric Breakdown									
M17		Hot Carrier Injection									
M18		Negative Bias Temperature Instability									
M19		Stress Migration									
M20		Electronic Discharge Human Body Model									
M21		Electronic Discharge Charged Device Model									
M22		Latch-up									
M23		Electrical Disturbance									
M24		Characterization									
M25		Electromagnetic Compatibility									
M26		Sheet Circuit Characterization									
M27		Self Error Rate									
M28		Lead Free									
M29		Hermetic Package Test									
M30		Package Drop									
M31		Die Shear									
M32		Internal Water Vapor									
M33		Whisker Test (IPC 6000-7.4.6, JEDEC J-1030)									
M34		Parameter Analysis (Comparison of systems with changed device characteristics, electrical distribution)									
M35		No Dr. Wet Products: Consider AEC-Q100									

## CURRENT PRODUCTS

Current products will be progressively replaced by the new device versions, with following approach:

- ✚ Silicon design: Cut 2.0 only will remain active
- ✚ Diffusion: Samsung only will remain active
- ✚ EWS: new site will be the main site for mass production, old site will remain active as a backup
- ✚ Assembly: new site will be the main site for mass production, old site will remain active as a backup, except for 64L package that will be active in ST Muar only
- ✚ Final test: new site will be the main site for mass production, old site will remain active as a backup

## REPORTS

Qualification of notified changes is presently in progress; relevant availability is indicatively expected in the following timeframe:

- ✚ samples: 2021Q2
- ✚ reports: 2021Q3

## ANNEX 1 – LIST OF ERRATA FIXES

ID	Module	Title	Cut 1.1	Cut 2.0
PS3022	STANDBY	STANDBY: Pad-Keeper functionality not immediately enabled on Low Power pads when entering in STANDBY Mode	X	Substituted by DAN-0051761 due to PAD Keeper Fix (*)
DAN-0051763	STANDBY	[DOC] WKPU: Wakeup/Interrupt Pullup Enable Register (WIPUER) description	-	Added due to PAD Keeper Fix (*)
DAN-0043003	CMU	CMU: False upper frequency threshold alarm signaled to FCCU	X	Fixed
DAN-0043294	MCAN	MCAN: Tx FIFO message sequence inversion	X	Fixed
DAN-0043334	MCAN	MCAN: Retransmission in DAR mode due to lost arbitration at the first two identifier bits.	X	Fixed
DAN-0047977	MCAN	Unexpected High Priority Message (HPM) interrupt.	X	Fixed
DAN-0047979	MCAN	Message transmitted with wrong arbitration and control fields	X	Fixed
PS1891	MCAN	Edge filtering causes mis-synchronization	X	Fixed
PS2206	MCAN	Configuration NBTP.NTSEG2 = '0' not allowed	X	Fixed
DAN-0042615	XOSC	XOSC: Oscillator4-40MHz Internal Capacitances	X	Fixed
DAN-0048760	PMC_Dig	PMC_Dig: HVD134_C (VD6) fake fault exiting STANDBY mode	X	Fixed

(\*) for more details on PAD Keeper features, please, refer to AN5484

Note: all the fixes do not generate any incompatibility with the workaround sw if maintained



## Public Products List

Public Products are off the shelf products. They are not dedicated to specific customers, they are available through ST Sales team, or Distributors, and visible on ST.com

**PCN Title :** SPC584Cx, SPC58ECx (FC80) : Design Improvement and New Manufacturing Plants Activation (Diffusion, EWS, Assembly, Testing)

**PCN Reference :** ADG/20/12360

**Subject :** Public Products List

Dear Customer,

Please find below the Standard Public Products List impacted by the change.

SPC584C70E3F000X	SPC58EC80E1Q0C0X	SPC58EC70E3F000X
SPC58EC80C3QMC0Y	SPC58EC74E3FMC0X	SPC58EC80E7QMC0Y
SPC58EC80C3Q0C0X	SPC58EC80C3QMC0X	SPC584C80E3G0C0X
SPC58EC80C3NEC0X	SPC58EC80E5FMC0X	SPC58EC80E3FMC0X
SPC584C70E7QMC0X	SPC58EC80E3QMC0X	SPC584C70E3FMC0X
SPC58EC70E1F0C0X	SPC58EC80E5QMC0X	SPC58EC74E7E0C0X
SPC58EC80E7G0C0X	SPC58EC80E5QMC0Y	SPC58EC80E3QMC0Y
SPC58EC74E3E0C0X	SPC58EC80E7QMC0X	SPC584C70E3GMC0X
SPC58EC80E5EMC0X	SPC58EC80E1Q0C0Y	SPC58EC74E7P000X
SPC58EC70E1F000X	SPC58EC80E7FMC0X	



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